

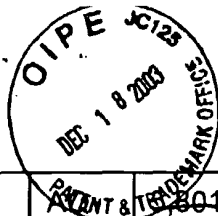


Sheet 1 of 2

Form PTO-1449 Modified  List of Patents and Publications Cited by Applicant (Use several sheets if necessary) U.S. Department of Commerce Patent and Trademark Office	Atty Docket No.: 16291-405	Serial No.: 10/658,950
	Applicant: Roman Skuratowicz	
	Filing Date: September 23, 2003	Group Art Unit: 1755

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DB	AA	2,749,336	06/05/56	Boddicker, et al.	260	231
	AB	3,015,572	01/02/62	Casey, et al.	106	197
	AC	3,723,413	03/27/73	Chatterjee, et al.	260	232
	AD	4,015,067	03/29/77	Lui, et al.	536	96
	AE	4,175,996	11/27/79	Battard, et al.	156	336
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	AL	4,853,437	08/01/89	Lukach, et al	525	54.21
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DB	AP	5,503,668	04/02/96	Giesfeldt, et al.	106	162



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*Examiner Initial	Doc. No.	Date	Country	Translation Yes No

#### OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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Examiner <i>DM Brusman</i>	Date Considered <i>12/4/04</i>
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\*Examiner: Initial if reference considered, whether or not citation is in conformation with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.